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8th **AUN/SEED-Net** REGIONAL CONFERENCE ON ELECTRICAL AND ELECTRONICS ENGINEERING

Envision, Enable, and Empower
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co-located with

11th **ERDT Conference** on Semiconductor and Electronics, Information and Communications Technology and Energy

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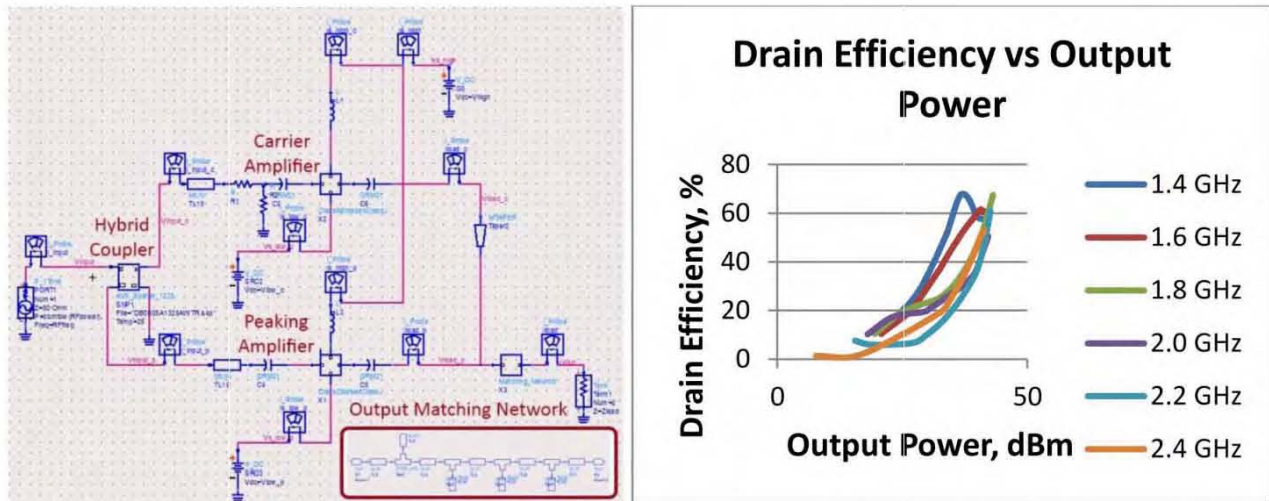


Figure 1. Class J-Tuned Doherty Amplifier Schematic (left), Drain Efficiency vs Output Power (right)

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